

# Dual 12-Bit, 250/210/170/125MSPS A/D Converter

### **General Description**

The KAD5612P is a family of low-power, high-performance, dual-channel 12-bit, analog-to-digital converters. Designed with Kenet's proprietary FemtoCharge® technology on a standard CMOS process, the family supports sampling rates of up to 250MSPS. The KAD5612P-25 is the fastest member of this pin-compatible family, which also features sample rates of 210MSPS (KAD5612P-21), 170MSPS (KAD5612P-17) and 125MSPS (KAD5612P-12).

A serial peripheral interface (SPI) port allows for extensive configurability, as well as fine control of gain, skew and offset matching between the two converter cores.

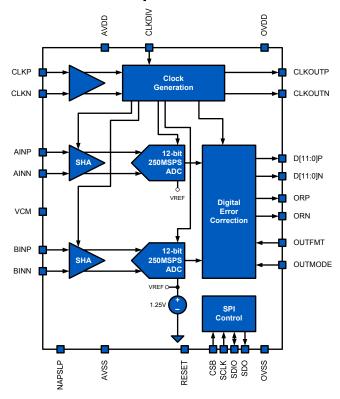
Digital output data is presented in selectable LVDS or CMOS formats. The KAD5612P is available in a 72-contact QFN package with an exposed paddle. Performance is specified over the full industrial temperature range (-40 to +85°C).

#### **Features**

- Programmable Gain, Offset and Skew control
- 1.3 GHz Analog Input Bandwidth
- 60fs Clock Jitter
- Over-Range Indicator
- Selectable Clock Divider: ÷1, ÷2 or ÷4
- Clock Phase Selection
- Nap and Sleep Modes
- Two's Complement, Gray Code or Binary Data Format
- DDR LVDS-Compatible or LVCMOS Outputs
- Programmable Built-in Test Patterns
- Single-Supply 1.8V Operation

#### **Applications**

- Power Amplifier Linearization
- Radar and Satellite Antenna Array Processing
- Broadband Communications
- High-Performance Data Acquisition
- Communications Test Equipment
- WiMAX and Microwave Receivers



## **Key Specifications**

- SNR = 65.1dBFS for  $f_{IN}$  = 124MHz (-1dBFS)
- SFDR = 80dBc for  $f_{IN} = 124MHz$  (-1dBFS)
- Power consumption
  - 405mW @ 250MSPS
  - 324mW @ 125MSPS

## **Pin-Compatible Family**

Model	Resolution	Speed (MSPS)
KAD5612P-25	12	250
KAD5612P-21	12	210
KAD5612P-17	12	170
KAD5612P-12	12	125
KAD5610P-25	10	250
KAD5610P-21	10	210
KAD5610P-17	10	170
KAD5610P-12	10	125

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## **Electrical Specifications**

All specifications apply under the following conditions unless otherwise noted: AVDD = 1.8V, OVDD = 1.8V,  $T_A = -40^{\circ}\text{C}$  to +85°C (typical specifications at 25°C),  $A_{IN} = -1 \, \text{dBFS}$ ,  $f_{SAMPLE} = Maximum$  Conversion Rate (per speed grade).

### **DC Specifications**

			KAD5612P-25		KA	D5612P	-21	KAD5612P-17			KAD5612P-12				
Parameter	Symbol	Conditions	Min	Тур	Max	Min	Тур	Max	Min	Тур	Max	Min	Тур	Max	Units
Analog Input															
Full-Scale Analog Input Range	$V_{\text{FS}}$	Differential	1.42	1.48	1.56	1.42	1.48	1.56	1.42	1.48	1.56	1.42	1.48	1.56	$V_{PP}$
Input Resistance	R <sub>IN</sub>	Differential		1000			1000			1000			1000		Ω
Input Capacitance	C <sub>IN</sub>	Differential		1.8			1.8			1.8			1.8		рF
Full Scale Range Temp. Drift	A <sub>VTC</sub>	Full Temp		90			90			90			90		ppm/°C
Input Offset Voltage	Vos		-10	±2	10	-10	±2	10	-10	±2	10	-10	±2	10	mV
Gain Error	Eg			±2			±2			±2			±2		%
Common-Mode Output Voltage	V <sub>СМ</sub>			0.535			0.535			0.535			0.535		٧
Power Requirements															
1.8V Analog Supply Voltage	AVDD		1.7	1.8	1.9	1.7	1.8	1.9	1.7	1.8	1.9	1.7	1.8	1.9	V
1.8V Digital Supply Voltage	OVDD		1.7	1.8	1.9	1.7	1.8	1.9	1.7	1.8	1.9	1.7	1.8	1.9	<b>V</b>
1.8V Analog Supply Current	l <sub>AVDD</sub>			157	165		146	154		134	142		118	126	mA
1.8V Digital Supply Current <sup>1</sup>	lovdd	3mA LVDS		68	76		66	74		64	72		62	70	mA
Power Supply Rejection Ratio	PSRR	30MHz, 200mVpp signal on		-36			-36			-36			-36		dB
Power Dissipation	-								-			-			
Normal Mode	PD	3mA LVDS		405	434		382	411		357	386		324	353	mW
Nap Mode	PD			134	146		129	142		124	138		118	131	mW
Sleep Mode	PD			14	16		13	16		7	15		12	13	mW

<sup>1.</sup> Digital Supply Current is dependent upon the capacitive loading of the digital outputs. I<sub>OVDD</sub> specifications apply for 10pF load on each digital output.



# AC Specifications<sup>1</sup>

			KAD5612P-25		KAD5612P-21			KAD5612P-17		KAD5612P-12					
Parameter	Symbol	Conditions	Min	Тур	Max	Min	Тур	Max	Min	Тур	Max	Min	Тур	Max	Units
Differential Nonlinearity	DNL		-1	±0.7		-1	±0.7		-1	±0.7		-1	±0.7		LSB
Integral Nonlinearity	INL			±1.6			±1.6			±1.6			±1.6		LSB
Minimum Conversion Rate <sup>2</sup>	fs MIN				40			40			40			40	MSPS
Maximum Conversion Rate	fs MAX		250			210			170			125			MSPS
Signal-to-Noise Ratio <sup>1</sup>	SNR	$f_{IN} = 10MHz$		65.2			65.8			66.2			66.7		dBFS
		f <sub>IN</sub> = 70MHz		65.1			65.7			66.2			66.6		dBFS
		$f_{IN} = 105MHz$	62.5	65.1		63.5	65.6		64.2	66.0		64.5	66.4		dBFS
		f <sub>IN</sub> = 230MHz		64.8			65.7			66.1			66.3		dBFS
		f <sub>IN</sub> = 400MHz		64.2									64.7		dBFS
		f <sub>IN</sub> = 995MHz		61.4									60.7		dBFS
Signal-to-Noise and Distortion <sup>1</sup>	SINAD	$f_{IN} = 10MHz$		64.0			65.5			66.0			66.4		dBFS
		f <sub>IN</sub> = 70MHz		64.0			65.7			65.9			66.3		dBFS
		$f_{IN} = 105MHz$	62.0	63.7		63.0	65.2		63.7	65.7		64.0	66.0		dBFS
		f <sub>IN</sub> = 230MHz		63.5			65.2			65.6			65.8		dBFS
		f <sub>IN</sub> = 400MHz		62.2									63.7		dBFS
		f <sub>IN</sub> = 995MHz		53.9									53.0		dBFS
Effective Number of Bits <sup>1</sup>	ENOB	$f_{IN} = 10MHz$		10.3			10.6			10.7			10.7		Bits
		f <sub>IN</sub> = 70MHz		10.3			10.6			10.7			10.7		Bits
		$f_{IN} = 105MHz$	10.0	10.3		10.2	10.5		10.3	10.6		10.3	10.7		Bits
		$f_{IN} = 230MHz$		10.3			10.5			10.6			10.6		Bits
		$f_{IN} = 400MHz$		10.0									10.3		Bits
		f <sub>IN</sub> = 995MHz		8.7									8.5		Bits
Spurious-Free Dynamic Range <sup>1</sup>	SFDR	$f_{IN} = 10MHz$		84			84			85			85		dBc
		f <sub>IN</sub> = 70MHz		84			83			82			83		dBc
		$f_{IN} = 105MHz$	70	80		70	80		70	80		70	80		dBc
		f <sub>IN</sub> = 230MHz		77			76			77			79		dBc
		f <sub>IN</sub> = 400MHz		71									76		dBc
		f <sub>IN</sub> = 995MHz		57									54		dBc
Intermodulation Distortion <sup>1</sup>	IMD	$f_{IN} = 70MHz$		-90.5									-96.5		dBFS
		$f_{IN} = 170MHz$		-86.0									-93.0		dBFS
Channel to Channel Isolation		$f_{IN} = 10MHz$		90			90			90			90		dB
		f <sub>IN</sub> = 124MHz		90			90			90			90		dB
Word Error Rate	WER			10-12			10-12			10-12			10-12		
Full Power Bandwidth	FPBW			1.3			1.3			1.3			1.3		GHz

<sup>1.</sup> AC Specifications apply after internal calibration of the ADC is invoked at the given sample rate and temperature. Refer to the **Power-On Calibration** and **User-Initiated Reset** sections for more details.

<sup>2.</sup> The DLL Range setting must be changed for low speed operation. See the **Serial Peripheral Interface** section for more detail.



# **Digital Specifications**

Parameter	Symbol	Conditions	Min	Тур	Max	Units
Inputs			•			
Input Current High (RESETN)	I <sub>IH</sub>	V <sub>IN</sub> = 1.8V	0	1	10	μΑ
Input Current Low (RESETN)	I <sub>IL</sub>	V <sub>IN</sub> = 0V	-25	-12	-5	μΑ
Input Current High (OUTMODE, NAP/SLP, CLKDIV, OUTFMT)	lін		15	25	40	μА
Input Current Low (OUTMODE, NAP/SLP, CLKDIV, OUTFMT)	I <sub>IL</sub>		-40	25	-15	μА
Input Capacitance	C <sub>DI</sub>			3		рF
LVDS Outputs			•			
Differential Output Voltage	V <sub>T</sub>	3mA Mode		620		mVpp
Output Offset Voltage	Vos	3mA Mode	950	965	980	mV
Output Rise Time	† <sub>R</sub>			500		ps
Output Fall Time	† <sub>F</sub>			500		ps
CMOS Outputs						
Voltage Output High	V <sub>OH</sub>	I <sub>OH</sub> = -500μA	OVDD-0.3	OVDD-0.1		٧
Voltage Output Low	V <sub>OL</sub>	I <sub>OL</sub> = 1mA		0.1	0.3	٧
Output Rise Time	† <sub>R</sub>			1.8		ns
Output Fall Time	† <sub>F</sub>			1.4		ns



## Absolute Maximum Ratings<sup>1</sup>

Parameter	Min	Max	Units
AVDD to AVSS	-0.4	2.1	٧
OVDD to OVSS	-0.4	2.1	٧
AVSS to OVSS	-0.3	0.3	٧
Analog Inputs to AVSS	-0.4	AVDD + 0.3	٧
Clock Inputs to AVSS	-0.4	AVDD + 0.3	٧
Logic Input to AVSS	-0.4	OVDD + 0.3	V
Logic Inputs to OVSS	-0.4	OVDD + 0.3	٧
Operating Temperature	-40	85	°C
Storage Temperature	-65	150	°C
Junction Temperature		150	°C

<sup>1.</sup> Exposing the device to levels in excess of the maximum ratings may cause permanent damage. Exposure to maximum conditions for extended periods may affect device reliability.

#### **Timing Diagrams**

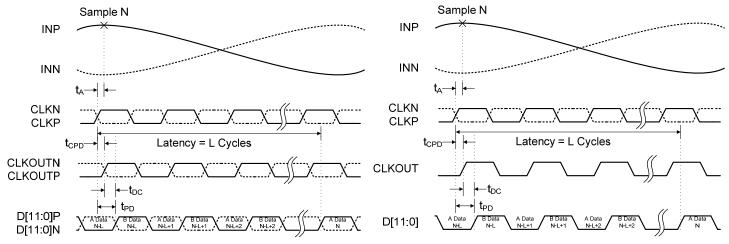


Figure 1. LVDS Timing Diagram—DDR

Figure 2. CMOS Timing Diagram—DDR



### **Switching Specifications**

Parameter	Condition	Symbol	Min	Тур	Max	Units
ADC	•	•	L			
Aperture Delay		† <sub>A</sub>		375		ps
RMS Aperture Jitter		j₄		60		fs
Output Clock to Data Propagation Delay, LVD\$ Mode	Rising Edge	t <sub>DC</sub>	-260	-50	120	ps
	Falling Edge	t <sub>DC</sub>	-160	10	230	ps
Output Clock to Data Propagation Delay, CMOS Mode	Rising Edge	t <sub>DC</sub>	-220	-10	200	ps
	Falling Edge	t <sub>DC</sub>	-310	-90	110	ps
Latency (Pipeline Delay)		L		7.5		cycles
Over Voltage Recovery		tovr		1		cycles
SPI Interface <sup>1,2</sup>	•					
SCLK Period	Write Operation	t <sub>CLK</sub>	64			ns
	Read Operation	t <sub>CLK</sub>	264			ns
SCLK Duty Cycle (thi/tclk or tlo/tclk)	Read or Write		25	50	75	%
SCLK↑ to CSB↓ Setup Time	Read or Write	ts	-4			ns
SCLK↑ to CSB↑ Hold Time	Read or Write	t <sub>H</sub>	-12			ns
SCLK↑ to Data Setup Time	Read or Write	t <sub>DS</sub>	-4			ns
SCLK↑ to Data Hold Time	Read or Write	t <sub>DH</sub>	-12			ns

<sup>1.</sup> SPI Interface timing is directly proportional to the ADC sample period (t<sub>s</sub>). Values above reflect multiples of a 4ns sample period, and must be scaled proportionally for lower sample rates.

## **Thermal Impedance**

Parameter	Symbol	Тур	Unit
Junction to Ambient <sup>3</sup>	ФЈА	27	°C/W

3. Paddle soldered to ground plane.

#### **ESD**



Electrostatic charge accumulates on humans, tools and equipment and may discharge through any metallic package contacts (pins, balls, exposed paddle, etc.) of an integrated circuit. Industry-standard protection techniques have been utilized in the design of this product. However, reasonable care must be taken in the storage and handling of ESD sensitive products. Contact Kenet for the specific ESD sensitivity rating of this product.



<sup>2.</sup> The SPI may operate asynchronously with respect to the ADC sample clock.

# **Pin Descriptions**

2.5. 17, 18, 28-31 DNC Do Not Connect 7, 10-12, 72 AVSS Analog Ground 8, 9 BINP, BINN B-Channel Analog Input Positive, Negative 13, 14 AINN, AINP A-Channel Analog Input Negative, Positive 15 VCM Common Mode Output 16 CLKDIV Clock Divider Control 20, 21 CLKP, CLKN Clock Input True, Complement 20, 22 OUTMODE Output Mode (LVDS, LVCMOS) 23 NAPSLP Power Control (Nap., Sleep modes) 24 RESEIN Power Control (Nap., Sleep modes) 25 RESEIN Power On Reset (Active Low) 26, 45, 55, 65 OVSS Output Ground 27, 36, 56 OVDD 1,8V Output Supply 28, 33 DON, DOP (NC, DO) LVDS BIT (Dutput Complement, True (NC, LVCMOS BIT 0) 39, 40 DIN, DIP (NC, DI) LVDS BIT 1 Output Complement, True (NC, LVCMOS BIT 1) 41, 42 DAN, DAP (NC, D3) LVDS BIT 3 Output Complement, True (NC, LVCMOS BIT 3) 43, 44 DSN, DSP (NC, D5) LVDS BIT 3 Output Complement, True (NC, LVCMOS BIT 3) 44, 44 DSN, DSP (NC, D5) LVDS BIT 5 Output Complement, True (NC, LVCMOS BIT 3) 45, 46 RLVDS LVDS BIT 5 Output Complement, True (NC, LVCMOS BIT 3) 47, 48 CLKOUTN, CLKOUTP (NC, D6) LVDS BIT 6 Output Complement, True (NC, LVCMOS BIT 6) 47, 48 CLKOUTN, CLKOUTP (NC, CLKOUT) LVDS BIT 7 Output Complement, True (NC, LVCMOS BIT 6) 47, 48 DEN, DSP (NC, D6) LVDS BIT 8 Output Complement, True (NC, LVCMOS BIT 6) 47, 48 CLKOUTN, CLKOUTP (NC, CLKOUT) LVDS BIT 9 Output Complement, True (NC, LVCMOS BIT 6) 47, 48 CLKOUTN, CLKOUTP (NC, CLKOUT) LVDS BIT 9 Output Complement, True (NC, LVCMOS BIT 6) 47, 50 D6N, D6P (NC, D6) LVDS BIT 8 Output Complement, True (NC, LVCMOS BIT 6) 48, 50 D7N, D7P (NC, D8) LVDS BIT 9 Output Complement, True (NC, LVCMOS BIT 6) 49, 50 D6N, D6P (NC, D8) LVDS BIT 9 Output Complement, True (NC, LVCMOS BIT 6) 40, 50 D6N, D6P (NC, D8) LVDS BIT 9 Output Complement, True (NC, LVCMOS BIT 6) 41, 42 D7N, D7P (NC, D8) LVDS BIT 9 Output Complement, True (NC, LVCMOS BIT 6) 42, 50 D7N, D7P (NC, D8) LVDS BIT 9 Output Complement, True (NC, LVCMOS BIT 6) 43, 44 D8N, D8P (NC, D8) LVDS BIT 9 Output Complement, True (NC, LVCMOS BIT 7) 44, 50 D7N, D7P (NC, D8) LVDS BIT 9 Output Complement, True (N	Pin #	LVD\$ [LVCMO\$] Name	LVDS [LVCMOS] Function
7, 10-12, 72         AVSS         Analog Ground           8, 9         BINP, BINN         B - Channel Analog Input Positive, Negative           13, 14         AINN, AINP         A - Channel Analog Input Negative, Positive           15         VCM         Common Mode Output           16         CLKDIV         Clock Divider Control           20, 21         CLKP, CLKN         Clock Input True, Complement           22         OUTMODE         Output Mode (LVDS, LVCMOS)           23         NAPSLP         Power Control (Nap., Sleep modes)           25         RESEIN         Power On Reset (Active Low)           26, 45, 55, 65         OVSS         Output Ground           27, 36, 56         OVDD         1,8V Output Supply           32, 33         DON, DOP [NC, D0]         LVDS Bit 1 Output Complement, True [NC, LVCMOS Bit 0]           34, 35         D1N, D1P [NC, D1]         LVDS Bit 2 Output Complement, True [NC, LVCMOS Bit 2]           39, 40         D3N, D3P [NC, D3]         LVDS Bit 3 Output Complement, True [NC, LVCMOS Bit 3]           41, 42         D4N, D4P [NC, D4]         LVDS Bit 3 Output Complement, True [NC, LVCMOS Bit 3]           45         LVDS DS DSP [NC, D5]         LVDS Bit 3 Output Complement, True [NC, LVCMOS Bit 3]           47, 48         CLKOUTN, CLKOUTP [NC, CLKOUT]	1, 6, 19, 24, 71	AVDD	1.8V Analog Supply
8, 9         BINP, BINN         B-Channel Analog Input Positive, Negative           13, 14         AINN, AINP         A-Channel Analog Input Negative, Positive           15         VCM         Common Mode Output           16         CIKDIV         Clock Divider Control           20, 21         CLKP, CLKN         Clock Input True, Complement           22         OUTMODE         Output Mode (LVDS, LVCMOS)           23         NAPSLP         Power Control (Nap, Siege modes)           25         RESETN         Power On Reset (Active Low)           26, 45, 55, 65         OVSS         Output Ground           27, 36, 56         CVDD         1,8Y Output Supply           32, 33         DON, DOP (NC, D0)         LVDS Bit 0 (LSB) Output Complement, True (NC, LVCMOS Bit 0)           34, 35         DIN, DIP (NC, D1)         LVDS Bit 1 Output Complement, True (NC, LVCMOS Bit 2)           39, 40         DSN, DSP (NC, D3)         LVDS Bit 3 Output Complement, True (NC, LVCMOS Bit 3)           41, 42         D4N, D4P (NC, D4)         LVDS Bit 4 Output Complement, True (NC, LVCMOS Bit 4)           44         RVDS         LVDS Bit 5 Output Complement, True (NC, LVCMOS Bit 5)           47, 48         CLKOUTN, CLKOUTP (NC, CLKOUT)         LVDS Bit 6 Output Complement, True (NC, LVCMOS Bit 6)           49, 50	2-5, 17, 18, 28-31	DNC	Do Not Connect
13, 14   AINN, AINP   A-Channel Analog Input Negative, Positive	7, 10-12, 72	AVSS	Analog Ground
15	8, 9	BINP, BINN	B-Channel Analog Input Positive, Negative
CLKDIV	13, 14	AINN, AINP	A-Channel Analog Input Negative, Positive
CLKP, CLKN   Clock Input True, Complement	15	VCM	Common Mode Output
22         OUTMODE         Output Mode (LVDS, LVCMOS)           23         NAPSLP         Power Control (Nap, Sleep modes)           25         RESETN         Power On Reset (Active Low)           26, 45, 55, 65         OVSS         Output Ground           27, 36, 56         OVDD         1.8V Output Supply           32, 33         D0N, D0P (NC, D0]         LVDS Bit 0 (LSB) Output Complement, True [NC, LVCMOS Bit 0]           34, 35         D1N, D1P (NC, D1]         LVDS Bit 1 Output Complement, True [NC, LVCMOS Bit 1]           37, 38         D2N, D2P (NC, D2)         LVDS Bit 2 Output Complement, True [NC, LVCMOS Bit 2]           39, 40         D3N, D3P (NC, D3)         LVDS Bit 3 Output Complement, True [NC, LVCMOS Bit 3]           41, 42         D4N, D4P (NC, D4)         LVDS Bit 4 Output Complement, True [NC, LVCMOS Bit 4]           43, 44         D5N, D5P (NC, D5)         LVDS Bit 5 Output Complement, True [NC, LVCMOS Bit 5]           47, 48         CLKOUTN, CLKOUTP (NC, CLKOUT)         LVDS Bias Resistor (connect to OVSS with a 10kΩ, 1% resistor)           49, 50         D6N, D6P (NC, D6)         LVDS Bit 6 Output Complement, True [NC, LVCMOS Bit 6]           51, 52         D7N, D7P (NC, D7)         LVDS Bit 7 Output Complement, True [NC, LVCMOS Bit 7]           53, 54         D8N, D8P (NC, D8)         LVDS Bit 80 Output Complement, True [NC, LVCMOS Bit 10] <td>16</td> <td>CLKDIV</td> <td>Clock Divider Control</td>	16	CLKDIV	Clock Divider Control
NAPSLP	20, 21	CLKP, CLKN	Clock Input True, Complement
25         RESETN         Power On Reset (Active Low)           26, 45, 55, 65         OVSS         Output Ground           27, 36, 56         OVDD         1,8V Output Supply           32, 33         DON, DOP [NC, D0]         LVDS Bit 0 (LSB) Output Complement, True [NC, LVCMOS Bit 0]           34, 35         D1N, D1P [NC, D1]         LVDS Bit 1 Output Complement, True [NC, LVCMOS Bit 1]           37, 38         D2N, D2P [NC, D2]         LVDS Bit 2 Output Complement, True [NC, LVCMOS Bit 2]           39, 40         D3N, D3P [NC, D3]         LVDS Bit 3 Output Complement, True [NC, LVCMOS Bit 3]           41, 42         D4N, D4P [NC, D4]         LVDS Bit 4 Output Complement, True [NC, LVCMOS Bit 4]           43, 44         D5N, D5P [NC, D5]         LVDS Bit 5 Output Complement, True [NC, LVCMOS Bit 5]           46         RLVDS         LVDS Bit 5 Output Complement, True [NC, LVCMOS Bit 5]           47, 48         CLKOUTN, CLKOUTP [NC, CLKOUT]         LVDS Clock Output Complement, True [NC, LVCMOS Bit 6]           49, 50         D6N, D6P [NC, D6]         LVDS Bit 6 Output Complement, True [NC, LVCMOS Bit 7]           51, 52         D7N, D7P [NC, D7]         LVDS Bit 7 Output Complement, True [NC, LVCMOS Bit 7]           57, 58         D9N, D9P [NC, D8]         LVDS Bit 8 Output Complement, True [NC, LVCMOS Bit 1]           59, 60         D10N, D10P [NC, D10]         LVD	22	OUTMODE	Output Mode (LVDS, LVCMOS)
26, 45, 55, 65         OVSS         Output Ground           27, 36, 56         OVDD         1.8V Output Supply           32, 33         DON, DOP [NC, D0]         LVDS Bit 0 (LSB) Output Complement, True [NC, LVCMOS Bit 0]           34, 35         D1N, D1P [NC, D1]         LVDS Bit 1 Output Complement, True [NC, LVCMOS Bit 1]           37, 38         D2N, D2P [NC, D2]         LVDS Bit 2 Output Complement, True [NC, LVCMOS Bit 2]           39, 40         D3N, D3P [NC, D3]         LVDS Bit 3 Output Complement, True [NC, LVCMOS Bit 3]           41, 42         D4N, D4P [NC, D4]         LVDS Bit 4 Output Complement, True [NC, LVCMOS Bit 4]           43, 44         D5N, D5P [NC, D5]         LVDS Bit 5 Output Complement, True [NC, LVCMOS Bit 5]           46         RLVDS         LVDS Bis a Resistor (connect to OVSS with a 10kQ, 1% resistor)           47, 48         CLKOUTN, CLKOUTP [NC, CLKOUT]         LVDS Clock Output Complement, True [NC, LVCMOS Bit 6]           49, 50         D6N, D6P [NC, D6]         LVDS Bit 6 Output Complement, True [NC, LVCMOS Bit 7]           51, 52         D7N, D7P [NC, D7]         LVDS Bit 8 Output Complement, True [NC, LVCMOS Bit 7]           53, 54         D8N, D8P [NC, D8]         LVDS Bit 9 Output Complement, True [NC, LVCMOS Bit 8]           57, 58         D9N, D9P [NC, D9]         LVDS Bit 10 Output Complement, True [NC, LVCMOS Bit 10]           64	23	NAPSLP	Power Control (Nap, Sleep modes)
27, 36, 56 OVDD 1.8V Output Supply 32, 33 D0N, D0P [NC, D0] LVDS Bit 0 (LSB) Output Complement, True [NC, LVCMOS Bit 0] 34, 35 D1N, D1P [NC, D1] LVDS Bit 1 Output Complement, True [NC, LVCMOS Bit 1] 37, 38 D2N, D2P [NC, D2] LVDS Bit 2 Output Complement, True [NC, LVCMOS Bit 2] 39, 40 D3N, D3P [NC, D3] LVDS Bit 3 Output Complement, True [NC, LVCMOS Bit 3] 41, 42 D4N, D4P [NC, D4] LVDS Bit 4 Output Complement, True [NC, LVCMOS Bit 4] 43, 44 D5N, D5P [NC, D5] LVDS Bit 5 Output Complement, True [NC, LVCMOS Bit 5] 46 RLVDS LVDS Bids Resistor (connect to OVSS with a 10kΩ, 1% resistor) 47, 48 CLKOUTN, CLKOUTP [NC, CLKOUT] LVDS Clock Output Complement, True [NC, LVCMOS CLKOUT] 49, 50 D6N, D6P [NC, D6] LVDS Bit 6 Output Complement, True [NC, LVCMOS Bit 6] 51, 52 D7N, D7P [NC, D7] LVDS Bit 7 Output Complement, True [NC, LVCMOS Bit 7] 53, 54 D8N, D8P [NC, D8] LVDS Bit 8 Output Complement, True [NC, LVCMOS Bit 7] 55, 58 D9N, D9P [NC, D9] LVDS Bit 9 Output Complement, True [NC, LVCMOS Bit 8] 57, 58 D9N, D9P [NC, D10] LVDS Bit 10 Output Complement, True [NC, LVCMOS Bit 10] 61, 62 D11N, D11P [NC, D11] LVDS Bit 11 (MSB) Output Complement, True [NC, LVCMOS Bit 11] 63, 64 ORN, ORP [NC, OR] LVDS Over Range Complement, True [NC, LVCMOS Over Range] 66 SDIO SPI Serial Data Output (4.7kΩ pull-up to OVDD is required) 67 CSB SPI Chip Select (active low) 68 SCLK SPI Clock 69 SDIO OUTFMT Output Data Format (Two's Comp., Gray Code, Offset Binary)	25	RESETN	Power On Reset (Active Low)
DON, DOP [NC, DO]   LVDS Bit 0 (LSB) Output Complement, True [NC, LVCMOS Bit 0]	26, 45, 55, 65	OVSS	Output Ground
D1N, D1P [NC, D1]   LVDS Bit 1 Output Complement, True [NC, LVCMOS Bit 1]	27, 36, 56	OVDD	1.8V Output Supply
37, 38 D2N, D2P [NC, D2] LVDS Bit 2 Output Complement, True [NC, LVCMOS Bit 2] 39, 40 D3N, D3P [NC, D3] LVDS Bit 3 Output Complement, True [NC, LVCMOS Bit 3] 41, 42 D4N, D4P [NC, D4] LVDS Bit 4 Output Complement, True [NC, LVCMOS Bit 4] 43, 44 DSN, D5P [NC, D5] LVDS Bit 5 Output Complement, True [NC, LVCMOS Bit 5] 46 RLVDS LVDS Bias Resistor (connect to OVSS with a 10kΩ, 1% resistor) 47, 48 CLKOUTN, CLKOUTP [NC, CLKOUT] LVDS Clock Output Complement, True [NC, LVCMOS CLKOUT] 49, 50 D6N, D6P [NC, D6] LVDS Bit 6 Output Complement, True [NC, LVCMOS Bit 6] 51, 52 D7N, D7P [NC, D7] LVDS Bit 7 Output Complement, True [NC, LVCMOS Bit 7] 53, 54 D8N, D8P [NC, D8] LVDS Bit 8 Output Complement, True [NC, LVCMOS Bit 8] 57, 58 D9N, D9P [NC, D9] LVDS Bit 9 Output Complement, True [NC, LVCMOS Bit 8] 57, 58 D9N, D9P [NC, D10] LVDS Bit 10 Output Complement, True [NC, LVCMOS Bit 10] 61, 62 D11N, D11P [NC, D11] LVDS Bit 11 [MSB) Output Complement, True [NC, LVCMOS Bit 11] 63, 64 ORN, ORP [NC, OR] LVDS Over Range Complement, True [NC, LVCMOS Over Range] 66 SDO SPI Serial Data Output (4.7kΩ pull-up to OVDD is required) 67 CSB SPI Clock 69 SDIO SPI Serial Data Input/Output 70 OUTFMT Output Data Format (Two's Comp., Gray Code, Offset Binary)	32, 33	D0N, D0P [NC, D0]	LVDS Bit 0 (LSB) Output Complement, True [NC, LVCMOS Bit 0]
19, 40 D3N, D3P [NC, D3] LVDS Bit 3 Output Complement, True [NC, LVCMOS Bit 3] 11, 42 D4N, D4P [NC, D4] LVDS Bit 4 Output Complement, True [NC, LVCMOS Bit 4] 143, 44 D5N, D5P [NC, D5] LVDS Bit 5 Output Complement, True [NC, LVCMOS Bit 5] 146 RLVDS LVDS Bias Resistor (connect to OVSS with a 10kΩ, 1% resistor) 147, 48 CLKOUTN, CLKOUTP [NC, CLKOUT] LVDS Clock Output Complement, True [NC, LVCMOS CLKOUT] 149, 50 D6N, D6P [NC, D6] LVDS Bit 6 Output Complement, True [NC, LVCMOS Bit 6] 151, 52 D7N, D7P [NC, D7] LVDS Bit 7 Output Complement, True [NC, LVCMOS Bit 7] 153, 54 D8N, D8P [NC, D8] LVDS Bit 8 Output Complement, True [NC, LVCMOS Bit 8] 157, 58 D9N, D9P [NC, D9] LVDS Bit 9 Output Complement, True [NC, LVCMOS Bit 9] 159, 60 D10N, D10P [NC, D10] LVDS Bit 10 Output Complement, True [NC, LVCMOS Bit 10] 161, 62 D11N, D11P [NC, D11] LVDS Bit 11 (MSB) Output Complement, True [NC, LVCMOS Bit 11] 163, 64 ORN, ORP [NC, OR] LVDS Over Range Complement, True [NC, LVCMOS Over Range] 164 SDO SPI Serial Data Output (4.7kΩ pull-up to OVDD is required) 165 CSB SPI Chip Select (active low) 166 SCLK SPI Clock 169 SDIO SPI Serial Data Input/Output 170 OUTFMT Output Data Format (Two's Comp., Gray Code, Offset Binary)	34, 35	DIN, DIP [NC, DI]	LVDS Bit 1 Output Complement, True [NC, LVCMOS Bit 1]
41, 42  D4N, D4P [NC, D4]  LVDS Bit 4 Output Complement, True [NC, LVCMOS Bit 4]  43, 44  D5N, D5P [NC, D5]  LVDS Bit 5 Output Complement, True [NC, LVCMOS Bit 5]  46  RLVDS  LVDS Bias Resistor (connect to OVSS with a 10kΩ, 1% resistor)  47, 48  CLKOUTN, CLKOUTP [NC, CLKOUT]  LVDS Clock Output Complement, True [NC, LVCMOS CLKOUT]  49, 50  D6N, D6P [NC, D6]  LVDS Bit 6 Output Complement, True [NC, LVCMOS Bit 6]  51, 52  D7N, D7P [NC, D7]  LVDS Bit 7 Output Complement, True [NC, LVCMOS Bit 7]  53, 54  D8N, D8P [NC, D8]  LVDS Bit 8 Output Complement, True [NC, LVCMOS Bit 8]  57, 58  D9N, D9P [NC, D9]  LVDS Bit 9 Output Complement, True [NC, LVCMOS Bit 9]  59, 60  D10N, D10P [NC, D10]  LVDS Bit 10 Output Complement, True [NC, LVCMOS Bit 10]  61, 62  D11N, D11P [NC, D11]  LVDS Bit 11 [MSB] Output Complement, True [NC, LVCMOS Bit 11]  63, 64  ORN, ORP [NC, OR]  LVDS Bit 11 [MSB] Output Complement, True [NC, LVCMOS Bit 11]  64, 65  SPI Serial Data Output (4.7kΩ pull-up to OVDD is required)  65  CSB  SPI Clock  SPI Clock  SPI Serial Data Input/Output  Output Data Format (Two's Comp., Gray Code, Offset Binary)	37, 38	D2N, D2P [NC, D2]	LVDS Bit 2 Output Complement, True [NC, LVCMOS Bit 2]
43, 44 D5N, D5P [NC, D5] LVDS Bit 5 Output Complement, True [NC, LVCMOS Bit 5] 46 RLVDS LVDS Bias Resistor (connect to OVSS with a 10kΩ, 1% resistor) 47, 48 CLKOUTN, CLKOUTP [NC, CLKOUT] LVDS Clock Output Complement, True [NC, LVCMOS CLKOUT] 49, 50 D6N, D6P [NC, D6] LVDS Bit 6 Output Complement, True [NC, LVCMOS Bit 6] 51, 52 D7N, D7P [NC, D7] LVDS Bit 7 Output Complement, True [NC, LVCMOS Bit 7] 53, 54 D8N, D8P [NC, D8] LVDS Bit 8 Output Complement, True [NC, LVCMOS Bit 8] 57, 58 D9N, D9P [NC, D9] LVDS Bit 9 Output Complement, True [NC, LVCMOS Bit 9] 59, 60 D10N, D10P [NC, D10] LVDS Bit 10 Output Complement, True [NC, LVCMOS Bit 10] 61, 62 D11N, D11P [NC, D11] LVDS Bit 11 [MSB) Output Complement, True [NC, LVCMOS Bit 11] 63, 64 ORN, ORP [NC, OR] LVDS Over Range Complement, True [NC, LVCMOS Over Range] 66 SDO SPI Serial Data Output (4.7kΩ pull-up to OVDD is required) 67 CSB SPI Chip Select (active low) 68 SCLK SPI Clock 69 SDIO SPI Serial Data Input/Output 70 OUTFMT Output Data Format (Two's Comp., Gray Code, Offset Binary)	39, 40	D3N, D3P [NC, D3]	LVDS Bit 3 Output Complement, True [NC, LVCMOS Bit 3]
46 RLVDS LVDS Bias Resistor (connect to OVSS with a 10kΩ, 1% resistor) 47, 48 CLKOUTN, CLKOUTP [NC, CLKOUT] LVDS Clock Output Complement, True [NC, LVCMOS CLKOUT] 49, 50 D6N, D6P [NC, D6] LVDS Bit 6 Output Complement, True [NC, LVCMOS Bit 6] 51, 52 D7N, D7P [NC, D7] LVDS Bit 7 Output Complement, True [NC, LVCMOS Bit 7] 53, 54 D8N, D8P [NC, D8] LVDS Bit 8 Output Complement, True [NC, LVCMOS Bit 8] 57, 58 D9N, D9P [NC, D9] LVDS Bit 9 Output Complement, True [NC, LVCMOS Bit 9] 59, 60 D10N, D10P [NC, D10] LVDS Bit 10 Output Complement, True [NC, LVCMOS Bit 10] 61, 62 D11N, D11P [NC, D11] LVDS Bit 11 (MSB) Output Complement, True [NC, LVCMOS Bit 11] 63, 64 ORN, ORP [NC, OR] LVDS Over Range Complement, True [NC, LVCMOS Over Range] 66 SDO SPI Serial Data Output (4.7kΩ pull-up to OVDD is required) 67 CSB SPI Chip Select (active low) 68 SCLK SPI Clock 69 SDIO SPI Serial Data Input/Output 70 OUTFMT Output Data Format (Two's Comp., Gray Code, Offset Binary)	41, 42	D4N, D4P [NC, D4]	LVDS Bit 4 Output Complement, True [NC, LVCMOS Bit 4]
47, 48 CLKOUTN, CLKOUTP [NC, CLKOUT] LVDS Clock Output Complement, True [NC, LVCMOS CLKOUT] 49, 50 D6N, D6P [NC, D6] LVDS Bit 6 Output Complement, True [NC, LVCMOS Bit 6] 51, 52 D7N, D7P [NC, D7] LVDS Bit 7 Output Complement, True [NC, LVCMOS Bit 7] 53, 54 D8N, D8P [NC, D8] LVDS Bit 8 Output Complement, True [NC, LVCMOS Bit 8] 57, 58 D9N, D9P [NC, D9] LVDS Bit 9 Output Complement, True [NC, LVCMOS Bit 9] 59, 60 D10N, D10P [NC, D10] LVDS Bit 10 Output Complement, True [NC, LVCMOS Bit 10] 61, 62 D11N, D11P [NC, D11] LVDS Bit 11 (MSB) Output Complement, True [NC, LVCMOS Bit 11] 63, 64 ORN, ORP [NC, OR] LVDS Over Range Complement, True [NC, LVCMOS Over Range] 66 SDO SPI Serial Data Output (4.7kΩ pull-up to OVDD is required) 67 CSB SPI Chip Select (active low) 68 SCLK SPI Clock 69 SDIO SPI Serial Data Input/Output 70 OUTFMT Output Data Format (Two's Comp., Gray Code, Offset Binary)	43, 44	D5N, D5P [NC, D5]	LVDS Bit 5 Output Complement, True [NC, LVCMOS Bit 5]
49, 50 D6N, D6P [NC, D6] LVDS Bit 6 Output Complement, True [NC, LVCMOS Bit 6] 51, 52 D7N, D7P [NC, D7] LVDS Bit 7 Output Complement, True [NC, LVCMOS Bit 7] 53, 54 D8N, D8P [NC, D8] LVDS Bit 8 Output Complement, True [NC, LVCMOS Bit 8] 57, 58 D9N, D9P [NC, D9] LVDS Bit 9 Output Complement, True [NC, LVCMOS Bit 9] 59, 60 D10N, D10P [NC, D10] LVDS Bit 10 Output Complement, True [NC, LVCMOS Bit 10] 61, 62 D11N, D11P [NC, D11] LVDS Bit 11 [MSB] Output Complement, True [NC, LVCMOS Bit 11] 63, 64 ORN, ORP [NC, OR] LVDS Over Range Complement, True [NC, LVCMOS Over Range] 66 SDO SPI Serial Data Output (4.7kΩ pull-up to OVDD is required) 67 CSB SPI Chip Select (active low) 68 SCLK SPI Clock 69 SDIO SPI Serial Data Input/Output 70 Output Data Format (Two's Comp., Gray Code, Offset Binary)	46	RLVDS	LVDS Bias Resistor (connect to OVSS with a $10k\Omega$ , $1\%$ resistor)
51, 52D7N, D7P [NC, D7]LVDS Bit 7 Output Complement, True [NC, LVCMOS Bit 7]53, 54D8N, D8P [NC, D8]LVDS Bit 8 Output Complement, True [NC, LVCMOS Bit 8]57, 58D9N, D9P [NC, D9]LVDS Bit 9 Output Complement, True [NC, LVCMOS Bit 9]59, 60D10N, D10P [NC, D10]LVDS Bit 10 Output Complement, True [NC, LVCMOS Bit 10]61, 62D11N, D11P [NC, D11]LVDS Bit 11 (MSB) Output Complement, True [NC, LVCMOS Bit 11]63, 64ORN, ORP [NC, OR]LVDS Over Range Complement, True [NC, LVCMOS Over Range]66SDOSPI Serial Data Output (4.7kΩ pull-up to OVDD is required)67CSBSPI Chip Select (active low)68SCLKSPI Clock69SDIOSPI Serial Data Input/Output70OUTFMTOutput Data Format (Two's Comp., Gray Code, Offset Binary)	47, 48	CLKOUTN, CLKOUTP [NC, CLKOUT]	LVDS Clock Output Complement, True [NC, LVCMOS CLKOUT]
D8N, D8P [NC, D8]  LVDS Bit 8 Output Complement, True [NC, LVCMOS Bit 8]  57, 58  D9N, D9P [NC, D9]  LVDS Bit 9 Output Complement, True [NC, LVCMOS Bit 9]  59, 60  D10N, D10P [NC, D10]  LVDS Bit 10 Output Complement, True [NC, LVCMOS Bit 10]  61, 62  D11N, D11P [NC, D11]  LVDS Bit 11 (MSB) Output Complement, True [NC, LVCMOS Bit 11]  63, 64  ORN, ORP [NC, OR]  LVDS Over Range Complement, True [NC, LVCMOS Over Range]  SPI Serial Data Output (4.7kΩ pull-up to OVDD is required)  SPI Chip Select (active low)  SPI Clock  SPI Clock  SPI Serial Data Input/Output  Output Data Format (Two's Comp., Gray Code, Offset Binary)	49, 50	D6N, D6P [NC, D6]	LVDS Bit 6 Output Complement, True [NC, LVCMOS Bit 6]
57, 58D9N, D9P [NC, D9]LVDS Bit 9 Output Complement, True [NC, LVCMOS Bit 9]59, 60D10N, D10P [NC, D10]LVDS Bit 10 Output Complement, True [NC, LVCMOS Bit 10]61, 62D11N, D11P [NC, D11]LVDS Bit 11 (MSB) Output Complement, True [NC, LVCMOS Bit 11]63, 64ORN, ORP [NC, OR]LVDS Over Range Complement, True [NC, LVCMOS Over Range]66SDOSPI Serial Data Output (4.7kΩ pull-up to OVDD is required)67CSBSPI Chip Select (active low)68SCLKSPI Clock69SDIOSPI Serial Data Input/Output70OUTFMTOutput Data Format (Two's Comp., Gray Code, Offset Binary)	51, 52	D7N, D7P [NC, D7]	LVDS Bit 7 Output Complement, True [NC, LVCMOS Bit 7]
59, 60 D10N, D10P [NC, D10] LVDS Bit 10 Output Complement, True [NC, LVCMOS Bit 10] 61, 62 D11N, D11P [NC, D11] LVDS Bit 11 (MSB) Output Complement, True [NC, LVCMOS Bit 11] 63, 64 ORN, ORP [NC, OR] LVDS Over Range Complement, True [NC, LVCMOS Over Range] 66 SDO SPI Serial Data Output (4.7kΩ pull-up to OVDD is required) 67 CSB SPI Chip Select (active low) 68 SCLK SPI Clock 69 SDIO SPI Serial Data Input/Output 70 OUTFMT Output Data Format (Two's Comp., Gray Code, Offset Binary)	53, 54	D8N, D8P [NC, D8]	LVDS Bit 8 Output Complement, True [NC, LVCMOS Bit 8]
D11N, D11P [NC, D11]   LVDS Bit 11 (MSB) Output Complement, True [NC, LVCMOS Bit 11]	57, 58	D9N, D9P [NC, D9]	LVDS Bit 9 Output Complement, True [NC, LVCMOS Bit 9]
63, 64 ORN, ORP [NC, OR] LVDS Over Range Complement, True [NC, LVCMOS Over Range] 66 SDO SPI Serial Data Output (4.7kΩ pull-up to OVDD is required) 67 CSB SPI Chip Select (active low) 68 SCLK SPI Clock 69 SDIO SPI Serial Data Input/Output 70 OUTFMT Output Data Format (Two's Comp., Gray Code, Offset Binary)	59, 60	D10N, D10P [NC, D10]	LVDS Bit 10 Output Complement, True [NC, LVCMOS Bit 10]
SPI Serial Data Output (4.7kΩ pull-up to OVDD is required)  SPI Chip Select (active low)  SPI Clock  SPI Clock  SPI Serial Data Input/Output  OUTFMT  Output Data Format (Two's Comp., Gray Code, Offset Binary)	61, 62	DIIN, DIIP [NC, DII]	LVDS Bit 11 (MSB) Output Complement, True [NC, LVCMOS Bit 11]
SPI Chip Select (active low)  SPI Chip Select (active low)  SPI Clock  SPI Serial Data Input/Output  OUTFMT  Output Data Format (Two's Comp., Gray Code, Offset Binary)	63, 64	ORN, ORP [NC, OR]	LVDS Over Range Complement, True [NC, LVCMOS Over Range]
SPI Clock  SPI Serial Data Input/Output  OUTFMT  Output Data Format (Two's Comp., Gray Code, Offset Binary)	66	SDO	SPI Serial Data Output (4.7kΩ pull-up to OVDD is required)
69 SDIO SPI Serial Data Input/Output 70 OUTFMT Output Data Format (Two's Comp., Gray Code, Offset Binary)	67	CSB	SPI Chip Select (active low)
70 OUTFMT Output Data Format (Two's Comp., Gray Code, Offset Binary)	68	SCLK	SPI Clock
	69	SDIO	SPI Serial Data Input/Output
Exposed Paddle AVSS Analog Ground	70	OUTFMT	Output Data Format (Two's Comp., Gray Code, Offset Binary)
	Exposed Paddle	AVSS	Analog Ground

LVCMOS Output Mode Functionality is shown in brackets (NC = No Connection)



## **Pin Configuration**

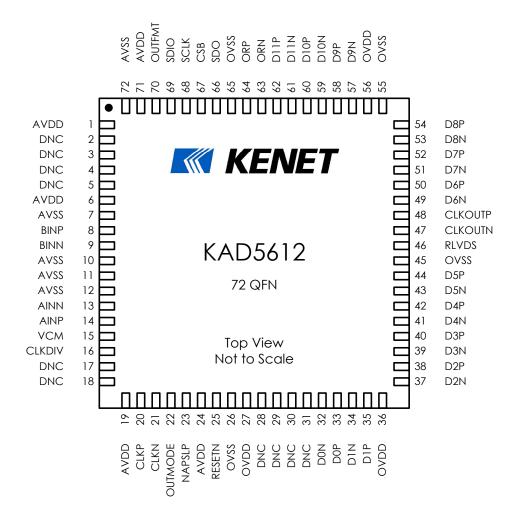
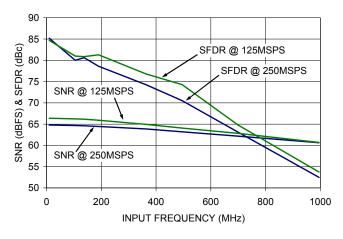


Figure 3. Pin Configuration



## **Typical Performance Curves**

All Typical Performance Characteristics apply under the following conditions unless otherwise noted: AVDD = OVDD = 1.8V,  $T_A = +25^{\circ}C$ ,  $A_{IN} = -1$ dBFS,  $f_{IN} = 105$ MHz,  $f_{SAMPLE} = Maximum$  Conversion Rate (per speed grade).



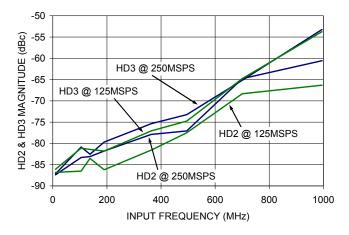


Figure 4. SNR & SFDR vs. fin

100 90 80 70 60 SNRFS (dBFS) 50 40 SFDR (dBc) 30 20 10

Figure 5. HD2 & HD3 vs. f<sub>IN</sub>

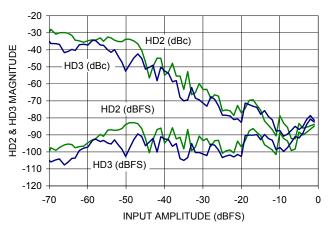


Figure 6. SNR & SFDR vs. AIN

INPUT AMPLITUDE (dBFS)

-40

-30

-10

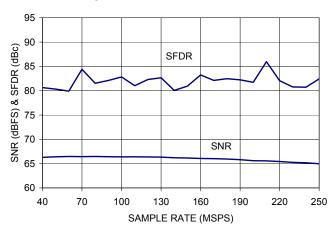


Figure 7. HD2 & HD3 vs. A<sub>IN</sub>

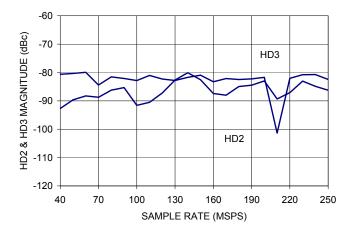


Figure 8. SNR & SFDR vs. fSAMPLE

Figure 9. HD2 & HD3 vs. fsample



SNR & SFDR

0

-70

-60

## **Typical Performance Curves**

All Typical Performance Characteristics apply under the following conditions unless otherwise noted: AVDD = 0.8V,  $T_A = +25$ °C,  $A_{IN} = -1 dBFS$ ,  $f_{IN} = 105 MHz$ ,  $f_{SAMPLE} = Maximum$  Conversion Rate (per speed grade).

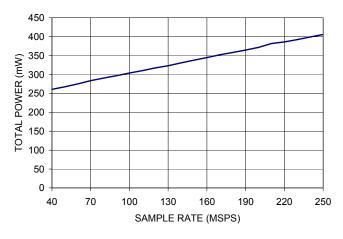


Figure 10. Power vs. f<sub>SAMPLE</sub> in 3mA LVDS Mode

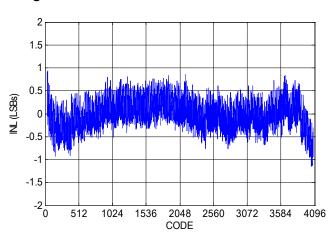


Figure 12. Integral Nonlinearity

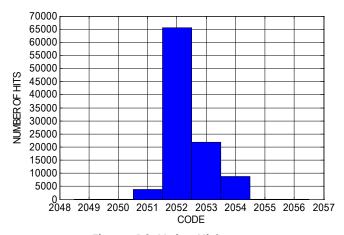


Figure 14. Noise Histogram

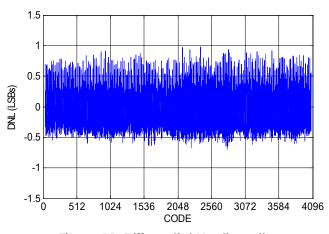


Figure 11. Differential Nonlinearity

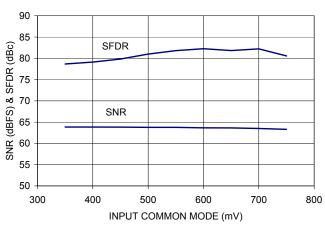


Figure 13. SNR & SFDR vs. VCM

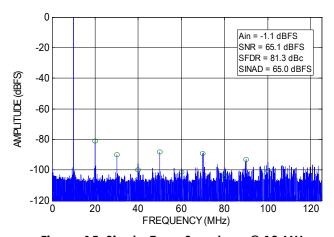


Figure 15. Single-Tone Spectrum @ 10 MHz



# **Typical Performance Curves**

All Typical Performance Characteristics apply under the following conditions unless otherwise noted: AVDD = OVDD = 1.8V,  $T_A = +25^{\circ}C$ ,  $A_{IN} = -1$ dBFS,  $f_{IN} = 105$ MHz,  $f_{SAMPLE} = Maximum$  Conversion Rate (per speed grade).

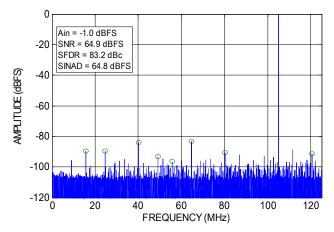


Figure 16. Single-Tone Spectrum @ 105 MHz

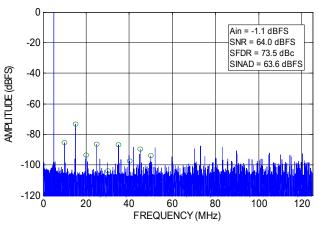


Figure 18. Single-Tone Spectrum @ 495MHz

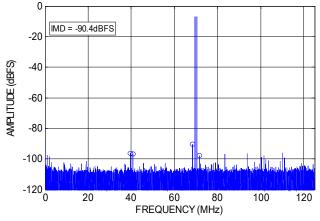


Figure 20. Two-Tone Spectrum @ 70 MHz

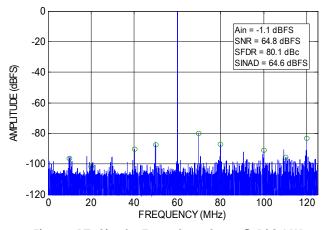


Figure 17. Single-Tone Spectrum @ 190 MHz

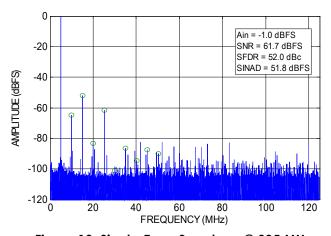


Figure 19. Single-Tone Spectrum @ 995 MHz

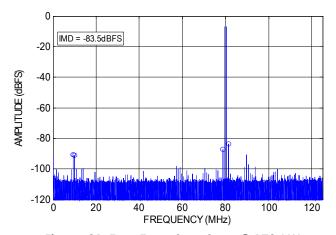


Figure 21. Two-Tone Spectrum @ 170 MHz



## **Functional Description**

The KAD5612P is based upon a 12-bit, 250MSPS A/D converter core that utilizes a pipelined successive approximation architecture (Figure 22). The input voltage is captured by a Sample-Hold Amplifier (SHA) and converted to a unit of charge. Proprietary charge-domain techniques are used to successively compare the input to a series of reference charges. Decisions made during the successive approximation operations determine the digital code for each input value. The converter pipeline requires six samples to produce a result. Digital error correction is also applied, resulting in a total latency of seven and one half clock cycles. This is evident to the user as a latency between the start of a conversion and the data being available on the digital outputs.

The device contains two A/D converter cores with carefully matched transfer characteristics. At startup, each core performs a self-calibration to minimize gain and offset errors. The reset pin (RESETN) is initially set high at power-up and will remain in that state until the calibration is complete. The clock frequency should remain fixed during this time, and no SPI communications should be attempted. Recalibration can be initiated via the SPI port at any time after the initial self-calibration.

#### **Power-On Calibration**

The ADC performs a self-calibration at start-up. An internal power-on-reset (POR) circuit detects the supply voltage ramps and initiates the calibration when the analog and digital supply voltages are above a threshold. The following conditions must be adhered to for the power-on calibration to execute successfully:

- A frequency-stable conversion clock must be applied to the CLKP/CLKN pins
- DNC pins (especially 3, 4 and 18) must not be pulled up or down
- SDO (pin 66) must be high
- RESETN (pin 25) must begin low
- SPI communications must not be attempted

A user-initiated reset can subsequently be invoked in the event that the above conditions cannot be met at power-up.

The SDO pin requires an external  $4.7k\Omega$  pull-up to OVDD. If the SDO pin is pulled low externally during power-up, calibration will not be executed properly.

After the power supply has stabilized the internal POR releases RESETN and an internal pull-up pulls it high, which starts the calibration sequence. If a subsequent user-initiated reset is required, the RESETN pin should be connected to an open-drain driver with a drive strenath of less than 0.5mA.

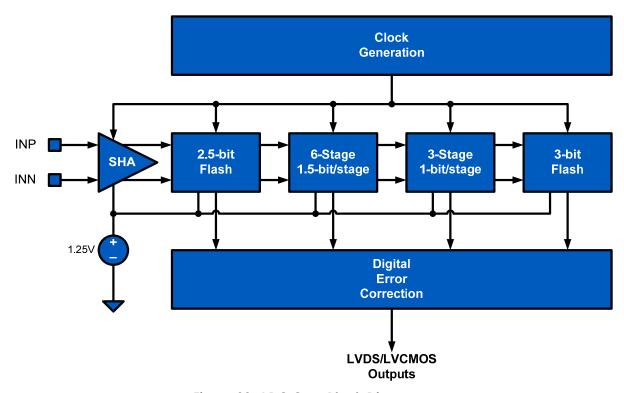


Figure 22. ADC Core Block Diagram



The calibration sequence is initiated on the rising edge of RESETN, as shown in Figure 23. The overrange output (OR) is set high once RESETN is pulled low, and remains in that state until calibration is complete. The OR output returns to normal operation at that time, so it is important that the analog input be within the converter's full-scale range to observe the transition. If the input is in an over-range condition the OR pin will stay high, and it will not be possible to detect the end of the calibration cycle.

While RESETN is low, the output clock (CLKOUTP/CLKOUTN) is set low. Normal operation of the output clock resumes at the next input clock edge (CLKP/CLKN) after RESETN is deasserted. At 250MSPS the nominal calibration time is 200ms, while the maximum calibration time is 550ms.

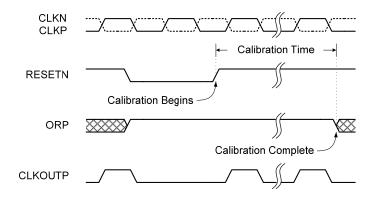


Figure 23. Calibration Timing

### **User-Initiated Reset**

Recalibration of the ADC can be initiated at any time by driving the RESETN pin low for a minimum of one clock cycle. An open-drain driver with a drive strength of less than 0.5mA is recommended. As is the case during power-on reset, the SDO, RESETN and DNC pins must be in the proper state for the calibration to successfully execute.

The performance of the KAD5612P changes with variations in temperature, supply voltage or sample rate. The extent of these changes may necessitate recalibration, depending on system performance requirements. Best performance will be achieved by recalibrating the ADC under the environmental conditions at which it will operate.

A supply voltage variation of less than 100mV will generally result in an SNR change of less than 0.5dBFS and SFDR change of less than 3dBc.

In situations where the sample rate is not constant, best results will be obtained if the device is calibrated

at the highest sample rate. Reducing the sample rate by less than 75MSPS will typically result in an SNR change of less than 0.5dBFS and an SFDR change of less than 3dBc.

Figures 25 and 26 show the effect of temperature on SNR and SFDR performance without recalibration. In each plot the ADC is calibrated at 25°C and temperature is varied over the operating range without recalibrating. The average change in SNR/SFDR is shown, relative to the 25°C value.

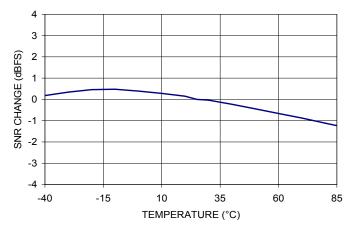


Figure 24. SNR Performance vs. Temperature after 25°C Calibration

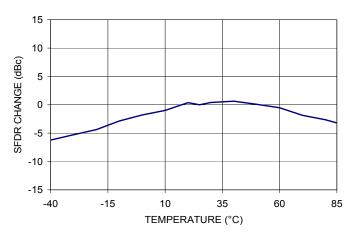


Figure 25. SFDR Performance vs. Temperature after 25°C Calibration

## **Analog Input**

Each ADC core contains a fully differential input (AINP/AINN, BINP/BINN) to the sample and hold amplifier (SHA). The ideal full-scale input voltage is 1.45V, centered at the VCM voltage of 0.535V as shown in Figure 26.



Best performance is obtained when the analog inputs are driven differentially. The common-mode output voltage, VCM, should be used to properly bias the inputs as shown in Figures 27 through 29.

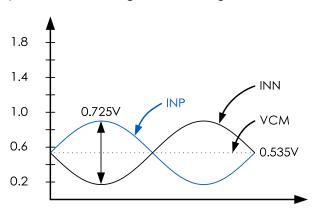


Figure 26. Analog Input Range

An RF transformer will give the best noise and distortion performance for wideband and/or high intermediate frequency (IF) inputs. Two different transformer input schemes are shown in Figures 27 and 28.

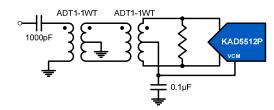


Figure 27. Transformer Input for General Purpose Applications

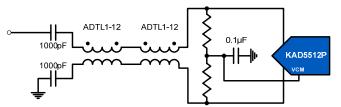


Figure 28. Transmission-line Transformer Input for High IF Applications

This dual transformer scheme is used to improve common-mode rejection, which keeps the common-mode level of the input matched to VCM. The value of the shunt resistor should be determined based on the desired load impedance. The differential input resistance of the KAD5612P is  $1000\Omega$ .

The SHA design uses a switched capacitor input stage (see Figure 42), which creates current spikes when the sampling capacitance is reconnected to the input voltage. This causes a disturbance at the input which must settle before the next sampling point. Lower source impedance will result in faster

settling and improved performance. Therefore a 1:1 transformer and low shunt resistance are recommended for optimal performance.

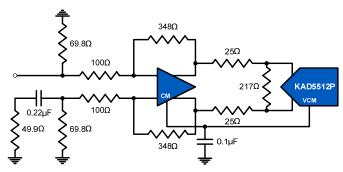


Figure 29. Differential Amplifier Input

A differential amplifier, as shown in Figure 29, can be used in applications that require dc-coupling. In this configuration the amplifier will typically dominate the achievable SNR and distortion performance.

## **Clock Input**

The clock input circuit is a differential pair (see Figure 43). Driving these inputs with a high level (up to  $1.8V_{PP}$  on each input) sine or square wave will provide the lowest jitter performance. A transformer with 4:1 impedance ratio will provide increased drive levels.

The recommended drive circuit is shown in Figure 30. A duty range of 40% to 60% is acceptable. The clock can be driven single-ended, but this will reduce the edge rate and may impact SNR performance. The clock inputs are internally self-biased to AVDD/2 to facilitate AC coupling.

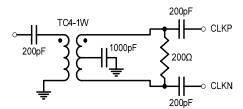


Figure 30. Recommended Clock drive

A selectable 2X frequency divider is provided in series with the clock input. The divider can be used in the 2X mode with a sample clock equal to twice the desired sample rate. This allows the use of the Phase Slip feature, which enables synchronization of multiple ADCs.



CLKDIV Pin	Divide Ratio
AVSS	2
Float	1
AVDD	4

Table 1. CLKDIV Pin Settings

The clock divider can also be controlled through the SPI port, which overrides the CLKDIV pin setting. Details on this are contained in the **Serial Peripheral Interface** section.

A delay-locked loop (DLL) generates internal clock signals for various stages within the charge pipeline. If the frequency of the input clock changes, the DLL may take up to 52µs to regain lock at 250MSPS. The lock time is inversely proportional to the sample rate.

#### **Jitter**

In a sampled data system, clock jitter directly impacts the achievable SNR performance. The theoretical relationship between clock jitter (t<sub>J</sub>) and SNR is shown in Equation 1 and is illustrated in Figure 31.

$$SNR = 20 \log_{10} \left( \frac{1}{2\pi f_{IN} t_J} \right)$$

#### Equation 1.

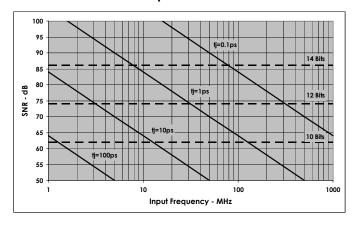


Figure 31. SNR vs. Clock Jitter

This relationship shows the SNR that would be achieved if clock jitter were the only non-ideal factor. In reality, achievable SNR is limited by internal factors such as linearity, aperture jitter and thermal noise. Internal aperture jitter is the uncertainty in the sampling instant shown in Figure 1. The internal aperture jitter combines with the input clock jitter in a root-sum-square fashion, since they are not statistically correlated, and this determines the total jitter in the

system. The total jitter, combined with other noise sources, then determines the achievable SNR.

## **Voltage Reference**

A temperature compensated voltage reference provides the reference charges used in the successive approximation operations. The full-scale range of each A/D is proportional to the reference voltage. The nominal value of the voltage reference is 1.25V.

## **Digital Outputs**

Output data is available as a parallel bus in LVDS-compatible or CMOS modes. In either case, the data is presented in double data rate (DDR) format with the A and B channel data available on alternating clock edges. When CLKOUT is low channel A data is output, while on the high phase channel B data is presented. Figures 1 and 2 show the timing relationships for LVDS and CMOS modes, respectively.

Additionally, the drive current for LVDS mode can be set to a nominal 3 mA or a power-saving 2 mA. The lower current setting can be used in designs where the receiver is in close physical proximity to the ADC. The applicability of this setting is dependent upon the PCB layout, therefore the user should experiment to determine if performance degradation is observed.

The output mode and LVDS drive current are selected via the OUTMODE pin as shown in Table 2.

OUTMODE Pin	Mode
AVSS	LVCMOS
Float	LVDS, 3 mA
AVDD	LVDS, 2 mA

Table 2. OUTMODE Pin Settings

The output mode can also be controlled through the SPI port, which overrides the OUTMODE pin setting. Details on this are contained in the **Serial Peripheral Interface** section.

An external resistor creates the bias for the LVDS drivers. A  $10k\Omega$ , 1% resistor must be connected from the RLVDS pin to OVSS.

## **Over Range Indicator**

The over range (OR) bit is asserted when the output code reaches positive full-scale (e.g. 0xFFF in offset binary mode). The output code does not wrap around during an over-range condition. The OR bit is updated at the sample rate.



## **Power Dissipation**

The power dissipated by the KAD5612P is primarily dependent on the sample rate and the output modes: LVDS vs. CMOS and DDR vs. SDR. There is a static bias in the analog supply, while the remaining power dissipation is linearly related to the sample rate. The output supply dissipation changes to a lesser degree in LVDS mode, but is more strongly related to the clock frequency in CMOS mode.

#### Nap/Sleep

Portions of the device may be shut down to save power during times when operation of the ADC is not required. Two power saving modes are available: Nap, and Sleep. Nap mode reduces power dissipation to less than 134mW and recovers to normal operation in approximately 1µs. Sleep mode reduces power dissipation to less than 14mW but requires 1ms to recover.

All digital outputs (Data, CLKOUT and OR) are placed in a high impedance state during Nap or Sleep. The input clock should remain running and at a fixed frequency during Nap or Sleep. Recovery time from Nap mode will increase if the clock is stopped, since the internal DLL can take up to 52µs to regain lock at 250MSPS.

By default after the device is powered on, the operational state is controlled by the NAPSLP pin as shown in Table 3.

NAPSLP Pin	Mode
AVSS	Normal
Float	Sleep
AVDD	Nap

Table 3. NAPSLP Pin Settings

The power down mode can also be controlled through the SPI port, which overrides the NAPSLP pin setting. Details on this are contained in the **Serial Peripheral Interface** section. This is an indexed function when controlled from the SPI, but a global function when driven from the pin.

#### **Data Format**

Output data can be presented in three formats: two's complement, Gray code and offset binary. The data format is selected via the OUTFMT pin as shown in Table 4.

OUTFMT Pin	Mode
AVSS	Offset Binary
Float	Two's Complement
AVDD	Gray Code

Table 4. OUTFMT Pin Settings

The data format can also be controlled through the SPI port, which overrides the OUTFMT pin setting. Details on this are contained in the **Serial Peripheral Interface** section.

Offset binary coding maps the most negative input voltage to code 0x000 (all zeros) and the most positive input to 0xFFF (all ones). Two's complement coding simply complements the MSB of the offset binary representation.

When calculating Gray code the MSB is unchanged. The remaining bits are computed as the XOR of the current bit position and the next most significant bit. Figure 32 shows this operation.

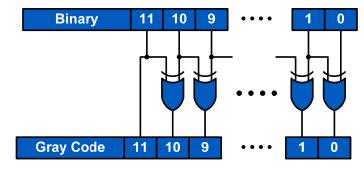


Figure 32. Binary to Gray Code Conversion

Converting back to offset binary from Gray code must be done recursively, using the result of each bit for the next lower bit as shown in Figure 33.

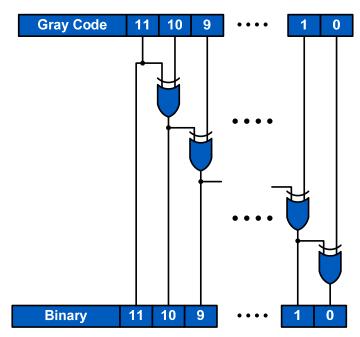


Figure 33. Gray Code to Binary Conversion

Mapping of the input voltage to the various data formats is shown in Table 5.

Input Voltage	Offset Binary	Two's Complement	Gray Code
-Full Scale	00000000000	10000000000	00000000000
-Full Scale + 1LSB	00000000001	10000000001	00000000001
Mid-Scale	100000000000	00000000000	110000000000
+Full Scale – 1LSB	111111111110	011111111110	10000000001
+Full Scale	1111111111111	011111111111	10000000000

Table 5. Input Voltage to Output Code Mapping

## Serial Peripheral Interface

A serial peripheral interface (SPI) bus is used to facilitate configuration of the device and to optimize performance. The SPI bus consists of chip select (CSB), serial clock (SCLK) serial data input (SDI), and serial data input/output (SDIO). The maximum SCLK rate is equal to the ADC sample rate (f<sub>SAMPLE</sub>) divided by 16 for write operations and f<sub>SAMPLE</sub> divided by 66 for reads. At f<sub>SAMPLE</sub> = 250MHz, maximum SCLK is 15.63MHz for writing and 3.79MHz for write operations. There is no minimum SCLK rate.

The following sections describe various registers that are used to configure the SPI or adjust performance or functional parameters. Many registers in the available address space (0x00 to 0xFF) are not defined in

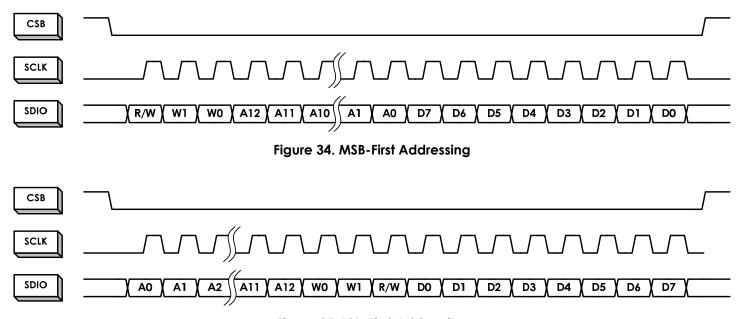


Figure 35. LSB-First Addressing



this document. Additionally, within a defined register there may be certain bits or bit combinations that are reserved. Undefined registers and undefined values within defined registers are reserved and should not be selected. Setting any reserved register or value may produce indeterminate results.

#### **SPI Physical Interface**

The serial clock pin (SCLK) provides synchronization for the data transfer. By default, all data is presented on the serial data input/output (SDIO) pin in three-wire mode. The state of the SDIO pin is set automatically in the communication protocol (described below). A dedicated serial data output pin (SDO) can be activated by setting 0x00[7] high to allow operation in four-wire mode.

The SPI port operates in a half duplex master/slave configuration, with the KAD5612P functioning as a

slave. Multiple slave devices can interface to a single master in four-wire mode only, since the SDIO output of an unaddressed device is asserted in three wire mode.

The chip-select bar (CSB) pin determines when a slave device is being addressed. Multiple slave devices can be written to concurrently, but only one slave device can be read from at a given time (again, only in four-wire mode). If multiple slave devices are selected for reading at the same time, the results will be indeterminate.

The communication protocol begins with an instruction/address phase. The first rising SCLK edge following a high to low transition on CSB determines the beginning of the two-byte instruction/address command. Data can be presented in MSB-first order or LSB-first order. The default is MSB-first, but this can be changed by setting 0x00[6] high. Figures 34 and 35

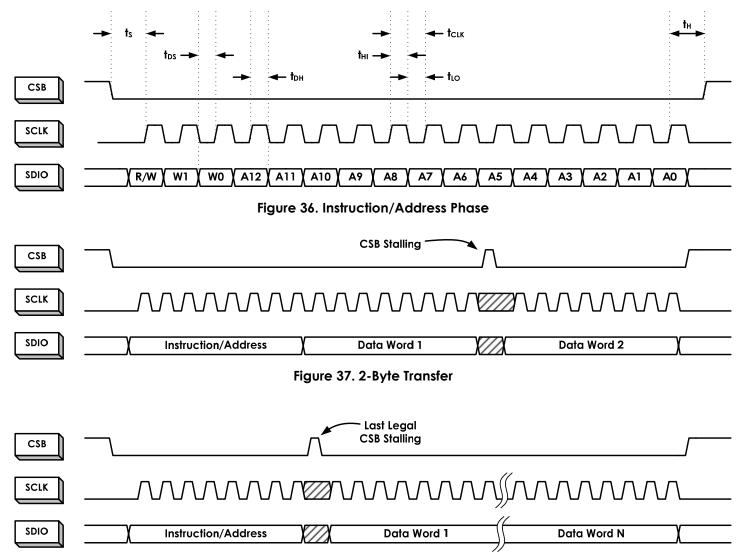


Figure 38. N-Byte Transfer



show the appropriate bit ordering for the MSB-first and LSB-first modes, respectively. In MSB-first mode the address is incremented for multi-byte transfers, while in LSB-first mode it's decremented.

In the default mode the MSB is R/W, which determines if the data is to be read (active high) or written. The next two bits, W1 and W0, determine the number of data bytes to be read or written (see Table 6). The lower 13 bits contain the first address for the data transfer. This relationship is illustrated in Figure 36, and timing values are given in the **Switching Specifications** section.

After the instruction/address bytes have been read, the appropriate number of data bytes are written to or read from the ADC (based on the R/W bit status). The data transfer will continue as long as CSB remains low and SCLK is active. Stalling of the CSB pin is allowed at any byte boundary (instruction/address or data) if the number of bytes being transferred is three or less. For transfers of four bytes or more, CSB is allowed stall in the middle of the instruction/address bytes or before the first data byte. If CSB transitions to a high state after that point the state machine will reset and terminate the data transfer.

[W1:W0]	Bytes Transferred
00	1
01	2
10	3
11	4 or more

Table 6. Byte Transfer Selection

Figures 37 and 38 illustrate the timing relationships for 2-byte and N-byte transfers, respectively. The operation for a 3-byte transfer can be inferred from these diagrams.

## **SPI** Configuration

#### Address 0x00: chip\_port\_config

Bit ordering and SPI reset are controlled by this register. Bit order can be selected as MSB to LSB (MSB first) or LSB to MSB (LSB first) to accommodate various microcontrollers.

Bit 7 SDO Active

Bit 6 LSB First

Setting this bit high configures the SPI to interpret serial data as arriving in LSB to MSB order.

Bit 5 Soft Reset

Setting this bit high resets all SPI registers to default values.

Bit 4 Reserved

This bit should always be set high.

Bits 3:0 These bits should always mirror bits 4:7 to avoid ambiguity in bit ordering.

#### Address 0x02: burst end

If a series of sequential registers are to be set, burst mode can improve throughput by eliminating redundant addressing. In 3-wire SPI mode the burst is ended by pulling the CSB pin high. If the device is operated in 2-wire mode the CSB pin is not available. In that case, setting the burst\_end address determines the end of the transfer. During a write operation, the user must be cautious to transmit the correct number of bytes based on the starting and ending addresses.

Bits 7:0 Burst End Address

This register value determines the ending address of the burst data.

#### **Device Information**

Address 0x08: chip\_id
Address 0x09: chip\_version

The generic die identifier and a revision number, respectively, can be read from these two registers.

#### Indexed Device Configuration/ Control

#### Address 0x10: device\_index\_A

A common SPI map, which can accommodate single-channel or multi-channel devices, is used for all Kenet ADC products. Certain configuration commands (identified as Indexed in the SPI map) can be executed on a per-converter basis. This register determines which converter is being addressed for an Indexed command. It is important to note that only a single converter can be addressed at a time.

This register defaults to 00h, indicating that no ADC is addressed. Error code 'AD' is returned if any indexed register is read from without properly setting device index A.

Address 0x20: offset\_coarse Address 0x21: offset fine

The input offset of each ADC core can be adjusted in fine and coarse steps. Both adjustments are made via an 8-bit word as detailed in Table 7.



The default value of each register will be the result of the self-calibration after initial power-up. If a register is to be incremented or decremented, the user should first read the register value then write the incremented or decremented value back to the same register.

Parameter	0x20[7:0] Coarse Offset	0x21[7:0] Fine Offset
Steps	255	255
-Full Scale (0x00)	-133LSB (-47mV)	-5LSB (-1.75mV)
Mid-Scale (0x80)	0.0LSB (0.0mV)	0.0LSB
+Full Scale (0xFF)	+133LSB (+47mV)	+5LSB (+1.75mV)
Nominal Step Size	1.04LSB (0.37mV)	0.04LSB (0.014mV)

Table 7. Offset Adjustments

Address 0x22: gain\_coarse
Address 0x23: gain\_medium
Address 0x24: gain fine

Gain of each ADC core can be adjusted in coarse, medium and fine steps. Coarse gain is a 4-bit adjustment while medium and fine are 8-bit.

The default value of each register will be the result of the self-calibration after initial power-up. If a register is to be incremented or decremented, the user should first read the register value then write the incremented or decremented value back to the same register.

0x22[3:0]	Nominal Coarse Gain Adjust
1100	4.2%
1000	2.8%
0100	1.4%
0000	0.0%
0001	-1.4%
0010	-2.8%
0011	-4.2%

Table 8. Coarse Gain Adjustment

Parameter	0x23[7:0] Medium Gain	0x24[7:0] Fine Gain
Steps	256	256
-Full Scale (0x00)	-2%	-0.2%
Mid-Scale (0x80)	0.0%	0.0%
+Full Scale (0xFF)	+2%	+0.2%
Nominal Step Size	0.016%	0.0016%

Table 9. Medium and Fine Gain Adjustments Address 0x25: modes

Two distinct reduced power modes can be selected. By default, the tri-level NAPSLP pin can select normal operation, nap or sleep modes (refer to Nap/Sleep section). This functionality can be overridden and controlled through the SPI. This is an indexed function when controlled from the SPI, but a global function when driven from the pin. This register is not changed by a Soft Reset.

Value	0x25[2:0] Power Down Mode
000	Pin Control
001	Normal Operation
010	Nap Mode
100	Sleep Mode

Table 10. Power Down Control

## **Global Device Configuration/Control**

#### Address 0x70: skew diff

The value in the skew\_diff register adjusts the timing skew between the two ADCs cores. The nominal range and resolution of this adjustment are given in Table 11. The default value of this register after power-up is 00h.

Parameter	0x70[7:0] Differential Skew
Steps	256
-Full Scale (0x00)	-6.5ps
Mid-Scale (0x80)	0.0ps
+Full Scale (0xFF)	+6.5ps
Nominal Step Size	51fs

Table 11. Differential Skew Adjustment



#### Address 0x71: phase\_slip

When using the clock divider, it's not possible to determine the synchronization of the incoming and divided clock phases. This is particularly important when multiple ADCs are used in a time-interleaved system. The phase slip feature allows the rising edge of the divided clock to be advanced by one input clock cycle, as shown in Figures 39 and 40. This register is self-clearing.

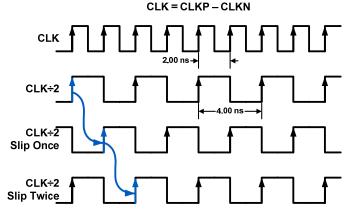


Figure 39. Phase Slip: CLK÷2 Mode, f<sub>CLOCK</sub>=500MHz CLK = CLKP – CLKN

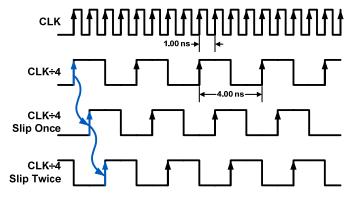


Figure 40. Phase Slip: CLK÷4 Mode, f<sub>CLOCK</sub>=1000MHz Address 0x72: clock\_divide

The KAD5612P has a selectable clock divider that can be set to divide by four, two or one (no division). By default, the tri-level CLKDIV pin selects the divisor (refer to **Clock Input** section). This functionality can be overridden and controlled through the SPI, as shown in Table 12. This register is not changed by a Soft Reset.

Value	0x72[2:0] Clock Divider
000	Pin Control
001	Divide by 1
010	Divide by 2
100	Divide by 4

Table 12. Clock Divider Selection

#### Address 0x73: output mode A

The output\_mode\_A register controls the physical output format of the data, as well as the logical coding. The KAD5612P can present output data in two physical formats: LVDS or LVCMOS. Additionally, the drive strength in LVDS mode can be set high (3mA) or low (2mA). By default, the tri-level OUTMODE pin selects the mode and drive level (refer to **Digital Outputs** section). This functionality can be overridden and controlled through the SPI, as shown in Table 13.

Data can be coded in three possible formats: two's complement, Gray code or offset binary. By default, the tri-level OUTFMT pin selects the data format (refer to **Data Format** section). This functionality can be overridden and controlled through the SPI, as shown in Table 14.

This register is not changed by a Soft Reset.

Value	0x93[7:5]
000	Pin Control
001	LVD\$ 2mA
010	LVD\$ 3mA
100	LVCMOS

Table 13. Output Mode Control

Value	0x93[2:0] Output Format
000	Pin Control
001	Two's Complement
010	Gray Code
100	Offset Binary

Table 14. Output Format Control

Address 0x74: output\_mode\_B Address 0x75: config\_status

Bit 6 DLL Range

This bit sets the DLL operating range to fast (default) or slow.



Internal clock signals are generated by a delay-locked loop (DLL), which has a finite operating range. Table 15 shows the allowable sample rate ranges for the slow and fast settings.

DLL Range	MIN	MAX	Unit		
Slow	40	100	MSPS		
Fast	80	f <sub>S</sub> MAX	MSPS		

Table 15. DLL Ranges

The output\_mode\_B and config\_status registers are used in conjunction to select the frequency range of the DLL clock generator. The method of setting these options is different from the other registers.

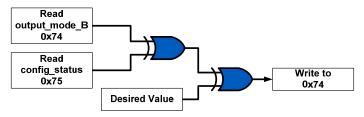


Figure 41 Setting output\_mode\_B register

The procedure for setting output\_mode\_B is shown in Figure 41. Read the contents of output\_mode\_B and config\_status and XOR them. Then XOR this result with the desired value for output\_mode\_B and write that XOR result to the register.

#### **Device Test**

The KAD5612 can produce preset or user defined patterns on the digital outputs to facilitate in-situ testing. A static word can be placed on the output bus, or two different words can alternate. In the alternate mode, the values defined as Word 1 and Word 2 (as shown in Table 16) are set on the output bus on alternating clock phases. The test mode is enabled asynchronously to the sample clock, therefore several sample clock cycles may elapse before the data is present on the output bus.

#### Address 0xC0: test io

Bits 7:6 User Test Mode

These bits set the test mode to static (0x00) or alternate (0x01) mode. Other values are reserved.

The four LSBs in this register (Output Test Mode) determine the test pattern in combination with registers 0xC2 through 0xC5. Refer to Table 17.

Value	0xC0[3:0] Output Test Mode	Word 1	Word 2		
0000	Off				
0001	Midscale	0x8000	N/A		
0010	Positive Full-Scale	0xFFFF	N/A		
0011	Negative Full-Scale	0x0000	N/A		
0100	Checkerboard	0xAAAA	0x5555		
0101	Reserved	N/A	N/A		
0110	Reserved	N/A	N/A		
0111	One/Zero	0xFFFF	0x0000		
1000	User Pattern	user_patt1	user_patt2		

Table 16. Output Test Modes

Address 0xC2: user\_patt1\_lsb Address 0xC3: user\_patt1\_msb

These registers define the lower and upper eight bits, respectively, of the first user-defined test word.

Address 0xC2: user\_patt2\_lsb Address 0xC3: user\_patt2\_msb

These registers define the lower and upper eight bits, respectively, of the second user-defined test word.



# **SPI Memory Map**

	Addr (Hex)	Parameter Name	Bit 7 (MSB)	Bit 6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	Bit O (LSB)	Def. Value (Hex)	Indexed/ Global
<u>.</u> D	00	port config	SDO Active	LSB First	Soft Reset			Mirror (bit5)	Mirror (bit6)	Mirror (bit7)	00h	G
SPI Config	01	reserved				Res	erved	, , , , , ,		,		
Ö	02	burst_end				Burst end	address [7:	0]			00h	G
SP	03-07	reserved		Reserved								
Info	08	chip_id					p ID #				Read only	G
므	09	chip_version				Chip \	ersion #				Read only	G
_	10	device_index_A	Reserved ADC01 ADC00						00h	- 1		
12	11-1F	reserved		Reserved								
lo:	20	offset_coarse		Coarse Offset							cal. value	
9/6	21 22	offset_fine gain_coarse	Fine Offset  Reserved Coarse Gain						cal. value	<u> </u>		
J. Li	23	gain_coaise gain medium		1/036	erveu	Medi	Jm Gain	Codi	se Guiii		cal. value	
ပိ	24	gain_mediam					Gain				cal. value	i
O	25	modes						Power Down	Mode [2:0]		00h	İ
Indexed Device Config/Control								000=Pin Cor	itrol		NOT	
								001=Normal	Operation		affected by	
9								010=Nap			Soft Reset	
ĝ								100=Sleep				
Ĕ								other codes	=reserved			
	26-5F	reserved					erved					
	60-6F	reserved					erved					
	70	skew_diff					ntial Skew			T	80h	G
	71	phase_slip				Reserved				Next Clock	00h	G
	72	clock divide	<u> </u>					Clask Divide	10.01	Edge	00h	G
	/ 2	Clock_divide	Clock Divide [2:0] 000=Pin Control						NOT	G		
_								001=divide k			affected by	
₽			010=divide by 1					Soft Reset				
Š		100-divide by 4 other codes=reserved										
9/0												
Global Device Config/Control	73	output_mode_A	Output Mode	e [2:0]				Output Form	at [2:0]		00h	G
Ö			000=Pin Con			000=Pin Control				NOT		
O			001=LVDS 2n		001=Twos Complement				affected by			
ē.			010=LVDS 3n					010=Gray C			Soft Reset	
			100=LVCMO					100=Offset B	•			
g	7.4	autout manda D	other codes		1			other codes	other codes=reserved			G
ĕ	74	output_mode_B		<b>DLL Range</b> 0=fast							00h NOT	G
				1=slow							affected by	
									Soft Reset			
	75	config_status		XOR Result								G
	76-BF	reserved	Reserved									
	C0	test_io	User Test Mo	de [2:0]	Reset PN	Reset PN	et PN Output Test Mode [3:0]				00h	G
			00=Single		Long Gen	Short Gen	ort Gen 0=Off 7=One/Zero Word Toggl					
			01=Alternate				1=Midscale Short 8=User Input 2=+FS Short 9-15=reserved					
			10=Single Or									
+			11=Alternate	Once			3=-FS Short					
les.			4=Checker Board									
Φ.			5=reserved									
Device Test			6=reserved									
ă	C1	Reserved					erved				00h	G
	C2	user_patt1_lsb	B7	B6	B5	B4	B3	B2	B1	B0	00h	G
	C3	user_patt1_msb	B15	B14	B13	B12	B11	B10	B9	B8	00h	G
	C4	user_patt2_lsb	B7	B6	B5	B4	B3	B2	B1	BO BO	00h	G
	C5	user_patt2_msb	B15	B14	B13	B12	B11	B10	В9	B8	00h	G
	C6-FF	F reserved Reserved					<u> </u>					

Table 17. SPI Memory Map



## **Equivalent Circuits**

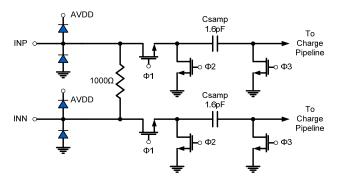


Figure 42. Analog Inputs

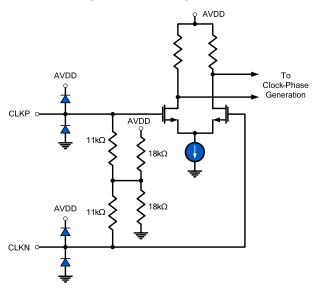


Figure 43. Clock Inputs

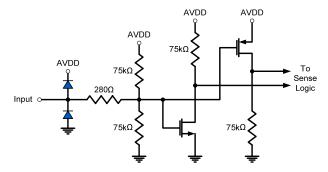


Figure 44. Tri-Level Digital Inputs

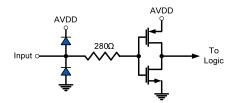


Figure 45. Digital Inputs

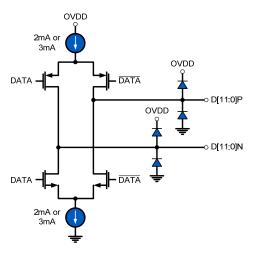


Figure 46. LVDS Outputs

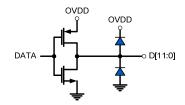


Figure 47. CMOS Outputs

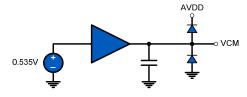


Figure 48. VCM OUT Output

## **Layout Considerations**

## **Split Ground and Power Planes**

Data converters operating at high sampling frequencies require extra care in PC board layout. Many complex board designs benefit from isolating the analog and digital sections. Analog supply and ground planes should be laid out under signal and clock inputs. Locate the digital planes under outputs and logic pins. Grounds should be joined under the chip.

### **Clock Input Considerations**

Use matched transmission lines to the transformer inputs for the analog input and clock signals. Locate transformers and terminations as close to the chip as possible.



#### **Exposed Paddle**

The exposed paddle must be electrically connected to analog ground (AVSS) and should be connected to a large copper plane using numerous vias for optimal thermal performance.

#### Bypass and Filtering

Bulk capacitors should have low equivalent series resistance. Tantalum is a good choice. For best performance, keep ceramic bypass capacitors very close to device pins. Longer traces will increase inductance, resulting in diminished dynamic performance and accuracy. Make sure that connections to ground are direct and low impedance. Avoid forming ground loops.

#### **LVDS Outputs**

Output traces and connections must be designed for  $50\Omega$  ( $100\Omega$  differential) characteristic impedance. Keep traces direct and minimize bends where possible. Avoid crossing ground and power-plane breaks with signal traces.

#### **LVCMOS Outputs**

Output traces and connections must be designed for  $50\Omega$  characteristic impedance.

### **Unused Inputs**

Standard logic inputs (RESETN, CSB, SCLK, SDIO, SDO) which will not be operated do not require connection to ensure optimal ADC performance. These inputs can be left floating if they are not used. Tri-level inputs (NAPSLP, OUTMODE, OUTFMT, CLKDIV) accept a floating input as a valid state, and therefore should be biased according to the desired functionality.

### **Definitions**

**Analog Input Bandwidth** is the analog input frequency at which the spectral output power at the fundamental frequency (as determined by FFT analysis) is reduced by 3dB from its full-scale low-frequency value. This is also referred to as Full Power Bandwidth.

Aperture Delay or Sampling Delay is the time required after the rise of the clock input for the sampling switch to open, at which time the signal is held for conversion.

**Aperture Jitter** is the RMS variation in aperture delay for a set of samples.

**Clock Duty Cycle** is the ratio of the time the clock wave is at logic high to the total time of one clock period.

**Differential Non-Linearity (DNL)** is the deviation of any code width from an ideal 1 LSB step.

**Effective Number of Bits (ENOB)** is an alternate method of specifying Signal to Noise-and-Distortion Ratio (SINAD). In dB, it is calculated as: ENOB = (SINAD-1.76) / 6.02

**Gain Error** is the ratio of the difference between the voltages that cause the lowest and highest code transitions to the full-scale voltage less 2 LSB. It is typically expressed in percent.

**Integral Non-Linearity (INL)** is the maximum deviation of the ADC's transfer function from a best fit line determined by a least squares curve fit of that transfer function, measured in units of LSBs.

**Least Significant Bit (LSB)** is the bit that has the smallest value or weight in a digital word. Its value in terms of input voltage is  $V_{FS}/(2^{N-1})$  where N is the resolution in bits.

**Missing Codes** are output codes that are skipped and will never appear at the ADC output. These codes cannot be reached with any input value.

**Most Significant Bit (MSB)** is the bit that has the largest value or weight.

**Pipeline Delay** is the number of clock cycles between the initiation of a conversion and the appearance at the output pins of the data.

**Power Supply Rejection Ratio (PSRR)** is the ratio of the observed magnitude of a spur in the ADC FFT, caused by an AC signal superimposed on the power supply voltage.

**Signal to Noise-and-Distortion (SINAD)** is the ratio of the RMS signal amplitude to the RMS sum of all other spectral components below one half the clock frequency, including harmonics but excluding DC.

**Signal-to-Noise Ratio** (without Harmonics) is the ratio of the RMS signal amplitude to the RMS sum of all other spectral components below one-half the sampling frequency, excluding harmonics and DC.

SNR and SINAD are either given in units of dB when the power of the fundamental is used as the reference, or dBFS (dB to full scale) when the converter's full-scale input power is used as the reference.

**Spurious-Free-Dynamic Range (SFDR)** is the ratio of the RMS signal amplitude to the RMS value of the largest spurious spectral component. The largest spurious spectral component may or may not be a harmonic.



**Two-Tone SFDR** is the ratio of the RMS value of the lowest power input tone to the RMS value of the peak spurious component, which may or may not be an IMD product.

#### **Outline Dimensions**

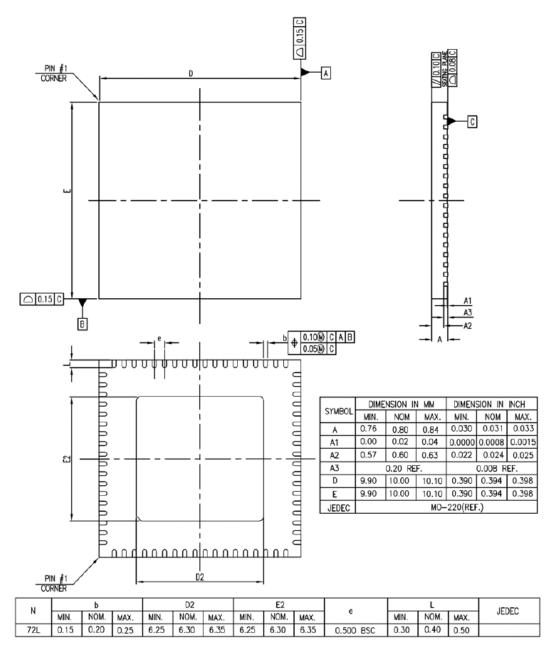


Figure 49. 72QFN Dimensions



## **Ordering Guide**



The KAD5612P is compliant with EU directive 2002/95/EC regarding the Restriction of Hazardous Substances (RoHS). Contact Kenet for a materials declaration for this product.

Model	Speed	Package	Temp. Range
KAD5612P-25Q72	250MSPS	72-QFN	-40°C to +85°C
KAD5612P-21Q72	210MSPS	72-QFN	-40°C to +85°C
KAD5612P-17Q72	170MSPS	72-QFN	-40°C to +85°C
KAD5612P-12Q72	125MSPS	72-QFN	-40°C to +85°C

## **Revision History**

30-Jul-08: Rev 1 Initial Release of Production Datasheet

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